

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/812,412	WANG ET AL.	
		Examiner	Art Unit	
		Nathan W. Ha	2814	Page 1 of 1

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*	B	US-6,974,991 B2	12-2005	Cheng et al.	257/302
*	C	US-2002/0190298 A1	12-2002	Alsmeier et al.	257/301
*	D	US-2004/0214391 A1	10-2004	Chen et al.	438/243
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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